

Search Notes

Application/Control No.

10/616,754

Examiner

M. Lee

Applicant(s)/Patent under
Reexamination

RENNER ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
348	547, 536, 537, 529, 511	5/7/2007	ML
375	376		
327	159, 157		
	156		
331	179		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/7/2007	ML